

# Issue Classification



Application/Control No.

10673916

Applicant(s)/Patent under Reexamination

CHANG ET AL.

Examiner

Apanius, Michael

Art Unit

3736

## ORIGINAL

CLASS

600

SUBCLASS

561

## INTERNATIONAL CLASSIFICATION

CLAIMED

A 6 1 B 5 / 00

NON-CLAIMED

## CROSS REFERENCE(S)

CLASS

SUBCLASS (ONE SUBCLASS PER BLOCK)

*Max Hindenburg*  
(Assistant Examiner)

9/11/2006  
(Date)

*Max Hindenburg*  
MAX F. HINDENBURG  
PATENT EXAMINER  
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Total Claims Allowed:  
8

*Q. Lee*  
(Legal Instruments Examiner)

9-12-06  
(Date)

(Primary Examiner)

(Date) 9/11/06

O.G.  
Print Claim(s)  
11

O.G.  
Print Figure  
10